MOSFET - Power, Dual **N-Channel** 40 V, 7.4 mΩ, 52 A

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- NVMFD5C466NLWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

| Parameter | | | Symbol | Value | Unit |
|---|-------------------------------------|------------------------|-----------------------------------|----------------|------|
| Drain-to-Source Voltage | | | V _{DSS} | 40 | V |
| Gate-to-Source Voltage | Gate-to-Source Voltage | | | ±20 | V |
| Continuous Drain | | T _C = 25°C | I _D | 52 | Α |
| Current R _{θJC} (Notes 1, 2, 3) | Steady | T _C = 100°C | | 37 | |
| Power Dissipation | State | T _C = 25°C | P_{D} | 38 | W |
| R _{θJC} (Notes 1, 2) | | T _C = 100°C | | 19 | |
| Continuous Drain | | T _A = 25°C | I _D | 15 | Α |
| Current R _{θJA} (Notes 1, 2, 3) | Steady | T _A = 100°C | | 11 | |
| Power Dissipation | State | T _A = 25°C | P_{D} | 3.0 | W |
| R _{θJA} (Notes 1, 2) | | T _A = 100°C | | 1.5 | |
| Pulsed Drain Current | $T_A = 25^{\circ}C, t_p = 10 \mu s$ | | I _{DM} | 198 | Α |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | -55 to +175 | °C |
| Source Current (Body Diode) | | | Is | 31.3 | Α |
| Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, I _{L(pk)} = 3 A) | | | E _{AS} | 72 | mJ |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | | | TL | 260 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
|---|-----------------|-------|------|
| Junction-to-Case - Steady State | $R_{\theta JC}$ | 4 | °C/W |
| Junction-to-Ambient - Steady State (Note 2) | $R_{\theta,IA}$ | 47.3 | |

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

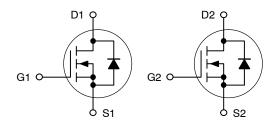


ON Semiconductor®

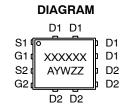
www.onsemi.com

| V _{(BR)DSS} | R _{DS(ON)} MAX | I _D MAX |
|----------------------|-------------------------|--------------------|
| 40 V | 7.4 mΩ @ 10 V | 52 A |
| | 12.6 mΩ @ 4.5 V | 52 A |

Dual N-Channel







MARKING

= Assembly Location

= Year

W = Work Week = Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

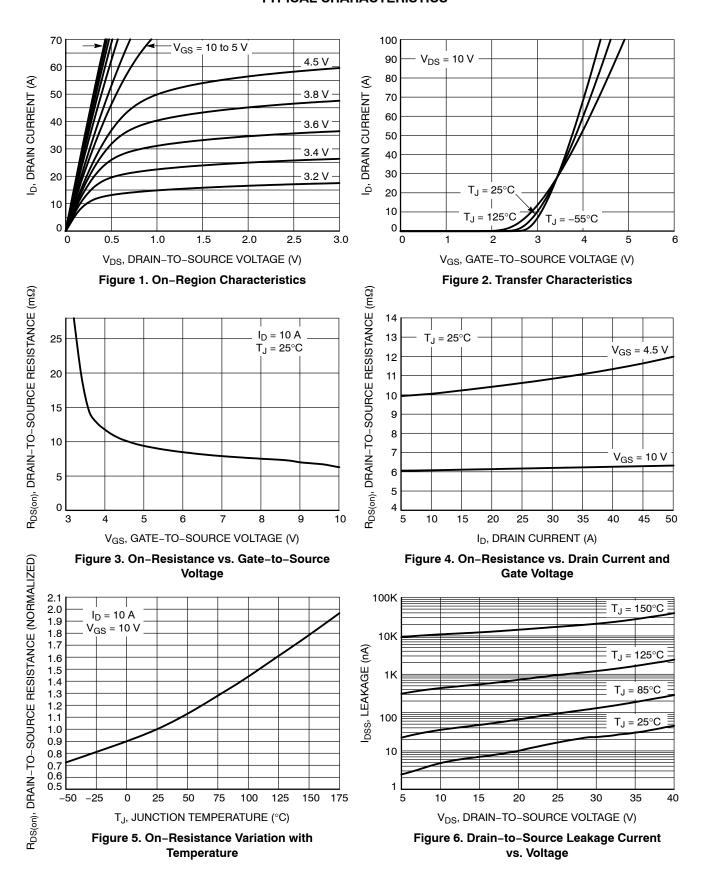
| Parameter | Symbol | Test Condition | | Min | Тур | Max | Unit |
|--|--|---|------------------------|-----|------|------|---------|
| OFF CHARACTERISTICS | | | | | • | • | • |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | | 40 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} / T _J | | | | 29 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | SS V _{GS} = 0 V, T _J = 25 °C | | | | 10 | |
| | | V _{DS} = 40 V | T _J = 125°C | | | 250 | μΑ |
| Gate-to-Source Leakage Current | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS}$ | _S = 20 V | | | 100 | nA |
| ON CHARACTERISTICS (Note 4) | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}$, $I_D = 30 \mu A$ | | 1.2 | | 2.2 | V |
| Negative Threshold Temperature Coefficient | V _{GS(TH)} /T _J | | | | -4.7 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = 10 A | | 6.2 | 7.4 | |
| | | V _{GS} = 4.5 V | I _D = 10 A | | 10 | 12.6 | 12.6 mΩ |
| Forward Transconductance | 9FS | V _{DS} = 15 V, I _D | ₎ = 25 A | | 33 | | S |
| CHARGES, CAPACITANCES & GATE RESIS | STANCE | | | | | | • |
| Input Capacitance | C _{ISS} | V _{GS} = 0 V, f = 1 MHz, V _{DS} = 25 V | | | 997 | | |
| Output Capacitance | C _{OSS} | | | | 354 | | pF |
| Reverse Transfer Capacitance | C _{RSS} | | | | 13 | | |
| Total Gate Charge | Q _{G(TOT)} | V _{GS} = 4.5 V, V _{DS} = 32 V; I _D = 25 A | | | 7.0 | | |
| Total Gate Charge | Q _{G(TOT)} | V _{GS} = 10 V, V _{DS} = 32 V; I _D = 25 A | | | 16 | | |
| Threshold Gate Charge | Q _{G(TH)} | V _{GS} = 4.5 V, V _{DS} = 32 V; I _D = 25 A | | | 1.5 | | nC |
| Gate-to-Source Charge | Q_{GS} | | | | 2.3 | | |
| Gate-to-Drain Charge | Q_{GD} | | | | 2.2 | | |
| Plateau Voltage | V_{GP} | | | | 3.3 | | V |
| SWITCHING CHARACTERISTICS (Note 5) | | | | | | | |
| Turn-On Delay Time | t _{d(ON)} | | | | 10 | | |
| Rise Time | t _r | V_{GS} = 4.5 V, V_{DS} = 32 V, I_{D} = 25 A, R_{G} = 1.0 Ω | | | 67 | | - ns |
| Turn-Off Delay Time | t _{d(OFF)} | | | | 26 | | |
| Fall Time | t _f | | | | 60 | | |
| DRAIN-SOURCE DIODE CHARACTERISTIC | s | | | | | | |
| Forward Diode Voltage | V_{SD} | V _{GS} = 0 V, | T _J = 25°C | | 0.9 | 1.2 | |
| | l _S : | I _S = 10 A | T _J = 125°C | | 0.7 | | V |
| Reverse Recovery Time | t _{RR} | V _{GS} = 0 V, dIS/dt = 100 A/μs, I _S = 25 A | | | 20 | | |
| Charge Time | t _a | | | | 10 | | ns |
| Discharge Time | t _b | | | | 10 | | |
| Reverse Recovery Charge | Q _{RR} | | | | 8 | | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

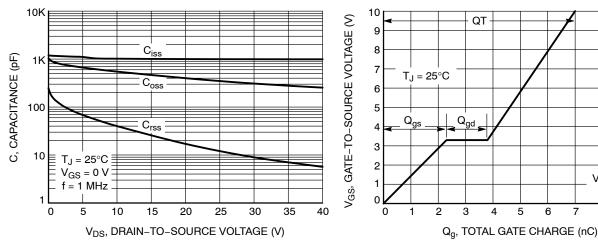


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source vs. Total Charge

V_{DS} = 32 V

 $I_D = 25 A$

9

10

8

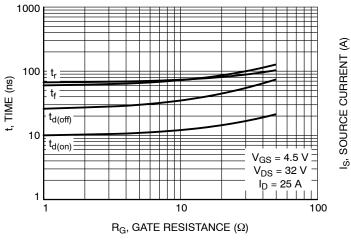


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

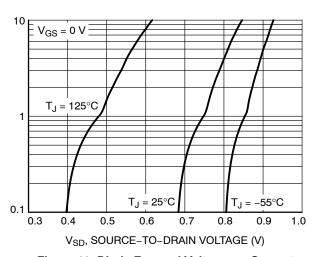


Figure 10. Diode Forward Voltage vs. Current

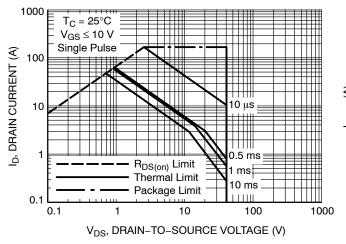


Figure 11. Maximum Rated Forward Biased Safe Operating Area

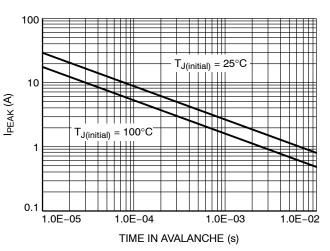


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS

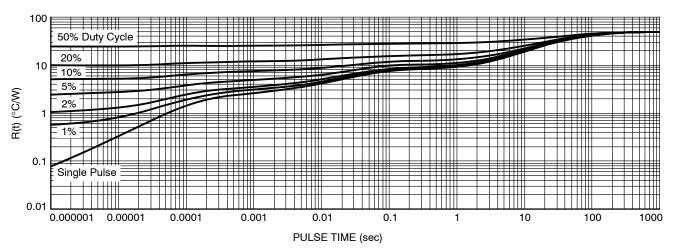
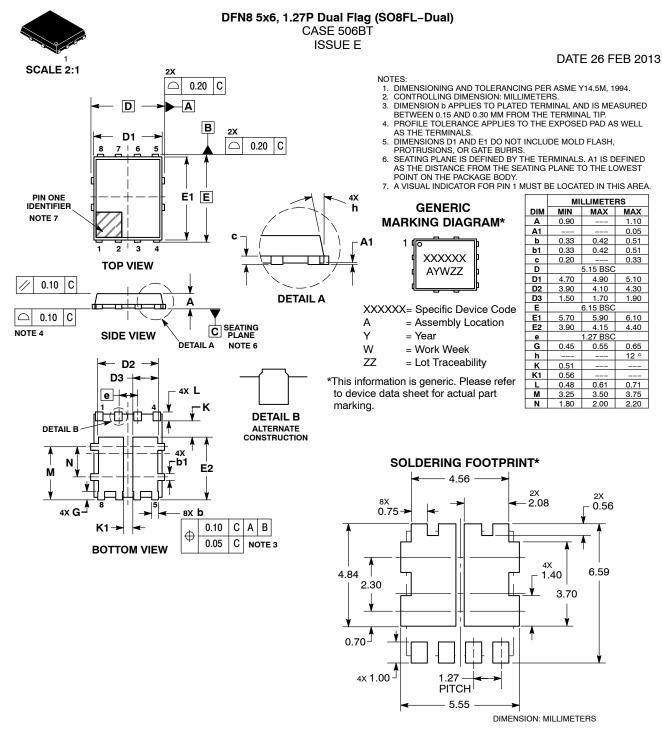


Figure 13. Thermal Response

DEVICE ORDERING INFORMATION

| Device | Marking | Package | Shipping [†] |
|-------------------|---------|------------------------------------|-----------------------|
| NVMFD5C466NLT1G | 5C466L | DFN8 (Pb-Free) | 1500 / Tape & Reel |
| NVMFD5C466NLWFT1G | 466LWF | DFN8 (Pb-Free, Wettable Flanks) | 1500 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

| DOCUMENT NUMBER: | 98AON50417E | Electronic versions are uncontrolled except when accessed directly from the Document Repositor Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red. | | |
|------------------|--|---|-------------|--|
| DESCRIPTION: | DFN8 5X6, 1.27P DUAL FLAG (SO8FL-DUAL) | | PAGE 1 OF 1 | |

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

ON Semiconductor and the are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor and see no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:
Email Requests to: orderlit@onsemi.com

ON Semiconductor Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative